

Notice of References Cited

Application/Control No.

10/820,298

Applicant(s)/Patent Under
Reexamination
SEFTON, JOHN

Examiner

Barbara P. Badio, Ph.D.

Art Unit

1616

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,775,529	10-1988	Sequeira et al.	514/171
	B	US-5,236,906	08-1993	Yamamoto, Toshiko	514/171
	C	US-5,650,279	07-1997	Nagpal et al.	435/6
	D	US-5,874,074	02-1999	Smith, James A.	424/78.02
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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